

<b>Notice of References Cited</b>	Application/Control No. 10/708,463		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner SIMON D. NGUYEN		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0199259	10-2003	Macedo et al.	455/141
*	B	US-2001/0035796	11-2001	Andrews, Joseph	331/117.00R
*	C	US-2002/0053953	05-2002	Edmonson et al.	333/17.3
*	D	US-6,825,818	11-2004	Toncich, Stanley S.	343/860
*	E	US-2005/0261797	11-2005	Cyr et al.	700/121
*	F	US-2004/0150483	08-2004	Cho, Je-Kwang	331/117.00R
*	G	US-2002/0193088	12-2002	Jung, Sang-II	455/191.2
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.